

Notice of References Cited	Application/Control No. 10/043,489	Applicant(s)/Patent Under Reexamination DUGAN ET AL	
	Examiner David E. Martinez	Art Unit 2182	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,327,621 B1	12-2001	Lee et al.	709/227
	B	US-5,564,040 A	10-1996	Kubala, Jeffrey P.	711/173
	C	US-6,046,989 A	04-2000	Takahashi, Eiichiro	370/312
	D	US-5,522,046 A	05-1996	McMillen et al.	709/239
	E	US-5,467,344 A	11-1995	Solomon et al.	370/396
	F	US-6,910,108 B2	06-2005	Downer et al.	711/141
	G	US-2003/0217154 A1	11-2003	Kasper, David J. II	709/227
	H	US-2002/0091786 A1	07-2002	Yamaguchi et al.	709/213
	I	US-6,807,579 B1	10-2004	Frazier, Giles R.	709/245
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.